

Dewetting of thin polymer films near the glass transition

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Dewetting of ultra-thin polymer films near the glass transition exhibits unexpected front morphologies [G. REITER, *Phys. Rev. Lett.*, **87**, 186101 (2001)]. We present here the first theoretical attempt to understand these features, focusing on the shear-thinning behaviour of these films. We analyse the profile of the dewetting film, and characterize the time evolution of the dry region radius, $R_d(t)$, and of the rim height, $h_m(t)$. After a transient time depending on the initial thickness, $h_m(t)$ grows like $\sqrt{t}$ while $R_d(t)$ increases like $\exp(\sqrt{t})$. Different regimes of growth are expected, depending on the initial film thickness and experimental time range.

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Thin liquids films are ubiquitous entities in science and technology. In engineering, for instance, they serve to protect surfaces, and applications arise in paints, adhesives and membranes [1]. Thin liquids films display a variety of interesting dynamics phenomena and have therefore been the focus of many experimental and theoretical studies [2]. Nearly half a century ago, Taylor [3] and Culick [4] analyzed the growth of a circular hole in a thin liquid sheet [5]. By balancing surface tension forces against inertia, they found that the rim of liquid at the edge of the films retracts at a constant velocity, a prediction first checked experimentally by Mc Entee and Mysels [6]. The precise shape of the rim was later analysed by Keller *et al.* [7, 8] who showed that it is a cylindrical cap expanding in time like $\sqrt{t}$. Recent experiments by Debrégeas and collaborators [9] on thin suspended films of very viscous liquids revealed unexpected features: (a) First, the retraction velocity grows exponentially with time (with a characteristic time scale $\tau_i = h_i \eta / |S|$, where h_i , η and S are respectively the initial film thickness, the viscosity and the spreading coefficient [10]), (b) second, the liquid is *not* collected into a rim and the film remains flat through the retraction. According to these authors, the uniform thickening of the retracting film was a consequence of its viscoelasticity, which permits an elastic propagation into the film of the surface tension forces acting on the edge. Solving numerically the Navier-Stokes equations for long wavelength modulations of the film, Brenner and Gueyffier [11] showed, however, that the absence of rim can also result from a purely viscous effect.

Very recently [12], Reiter studied the dewetting of ultrathin (*i.e.* thinner than the coil size), almost glassy polystyrene (PS) films deposited onto silicon wafers coated with a polydimethylsiloxane (PDMS) monolayer. He found that a highly asymmetric rim, with an extremely steep side towards the interior of the hole and

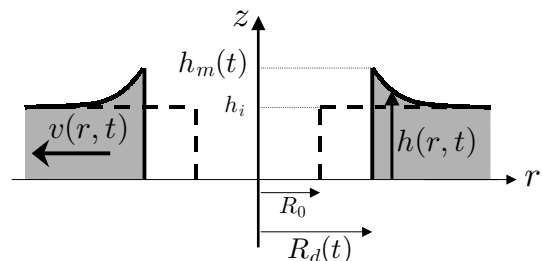


FIG. 1: Film geometry: $h(r, t)$ is the profile of the film, $h_m(t)$ is the height of the rim, and $R_d(t)$ is the radius of the dry zone. The initial ($t = 0$) step-like profile is represented by the dashed line. $v(r, t)$ is the radial, axisymmetric flow field [14].

a much slower decay on the rear side, builds up progressively [13]. In this Letter we present the first theoretical attempt to understand these new features. Figure 1 shows the film geometry.

In order to characterise the rheologic properties of the film, we introduce the stress tensor $\sigma_{ij} = -p\delta_{ij} + \sigma_{ij}^m$, where p is the pressure and σ_{ij}^m represents the effects of internal friction. We relate σ_{ij}^m to the strain rate tensor $\dot{\gamma}_{ij}$ by a constitutive law of the form:

$$\sigma^m(\dot{\gamma}) = \sigma_0 \Phi(\dot{\gamma}\tau) \quad (1)$$

where σ_0 and τ are material constants, and Φ is a generic function. For a purely viscous liquid, the function Φ is linear, whereas for polymers, just above T_g , it can be shown within the framework of the free-volume model [15] that σ^m is expected to vary logarithmically with $\dot{\gamma}$ as [16]:

$$\Phi(\dot{\gamma}\tau) = \ln(1 + \dot{\gamma}\tau) \quad (2)$$

At low strain-rates ($\dot{\gamma}\tau < 1$), this law displays a viscous-type behaviour ($\sigma^m \approx \eta_0 \dot{\gamma}$, with a zero-shear viscosity $\eta_0 = \sigma_0 \tau$), while for large values of $\dot{\gamma}\tau$, σ^m reaches an almost constant value (shear-thinning behaviour).

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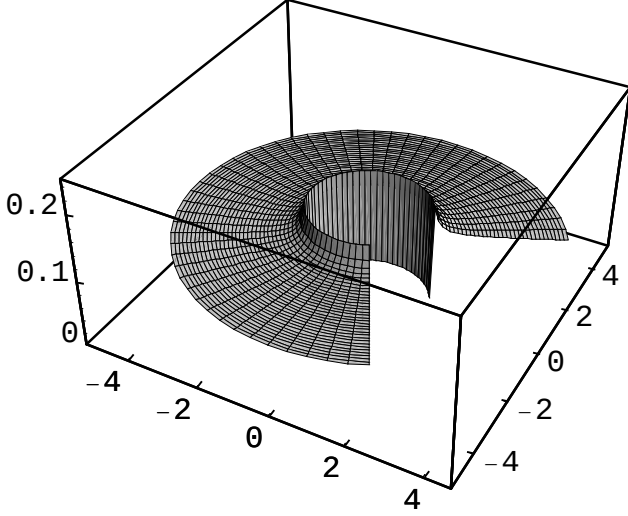


FIG. 2: Film profile for $h_i = 0.1h^*$ and $t = 10^{-2}\tau$. For clarity reasons, a sectional view is displayed on a quarter of circle.

Assuming the fluid to be incompressible, mass conservation leads to:

$$\frac{1}{h(r, t)} \left(\frac{\partial h(r, t)}{\partial t} + \frac{r\beta(r, t)}{\tau} \frac{\partial h(r, t)}{\partial r} \right) = \frac{\alpha(r, t) - \beta(r, t)}{\tau} \quad (3)$$

Equation 3 involves two unknown functions $\alpha(r, t)$ and $\beta(r, t)$, that are positive, dimensionless forms of the strain-rate components $\dot{\gamma}_{rr}$ and $\dot{\gamma}_{\phi\phi}$:

$$\begin{cases} \alpha = -\tau \dot{\gamma}_{rr} = -\tau \frac{\partial v}{\partial r} \\ \beta = \tau \dot{\gamma}_{\phi\phi} = \tau \frac{v}{r} \end{cases} \quad (4)$$

We thus need two additional equations to determine $h(r, t)$. First, note that the following partial differential equation can be directly derived from Eq.4:

$$\frac{\partial \beta}{\partial r} = -\frac{\beta + \alpha}{r} \quad (5)$$

Neglecting the inertial term, conservation of momentum (projected on the radial direction [17]) leads to:

$$\frac{\partial \sigma_{rr}}{\partial r} + \frac{\sigma_{rr} - \sigma_{\phi\phi}}{r} = 0 \quad (6)$$

It can be shown that Eqs. 5 and 6, along with the free-surface boundary condition (*i.e.* $\sigma_{zz} = 0$ at the contact with ambient atmosphere [18]), allow one to express the strain rate α as a function of β only : $\alpha = F(\beta)$. Substitution of the constitutive law 1 in Eq.6 then leads to the following differential equation for F :

$$\frac{d[\Phi(F(\beta)) - \Phi(F(\beta) - \beta)]}{d\beta} = \frac{\Phi(F(\beta)) - \Phi(\beta)}{F(\beta) + \beta} \quad (7)$$

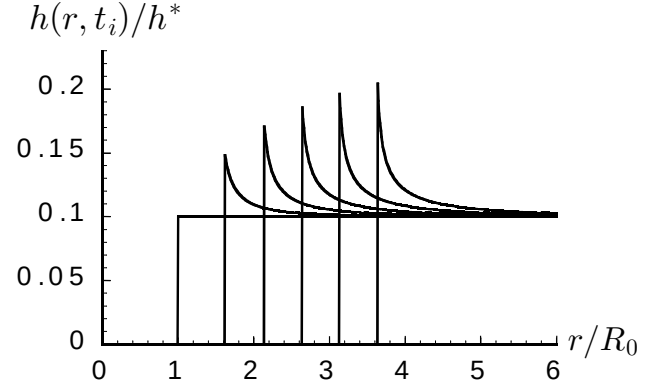


FIG. 3: Evolution of the film profile $h(r, t)$ for $h_i = 0.1h^*$ and t ranging from $t = 0$ to $t = 5 \cdot 10^{-2}\tau$ with a time step of $10^{-2}\tau$.

which has to be solved along with the condition $F(0) = 0$ (far away from the perturbed central region, the strain rates must decrease to zero).

In order to solve Eq.3, we should supply it with initial and boundary conditions. Our initial profile is assumed to be uniform, with a thickness h_i , except in a bored region ranging from $r = 0$ to $r = R_0$ (as shown in fig.1). R_0 is our characteristic radial length used thereafter to make r dimensionless:

$$h(r, t = 0) = \begin{cases} h_i & \text{if } r \geq R_0 = 1 \\ 0 & \text{otherwise} \end{cases} \quad (8)$$

We do not consider here the origin of the initial dewetting process: experimentally, it is found that a thick PS film on a silicon substrate is metastable and dewets via nucleation and growth of dry patches [19], while thinner films ($h_i < 100$ nm) are unstable and dewet by spinodal decomposition [20]. In his latest experiments on ultra-thin films [12], Reiter characterized the early stage of the dewetting process by the formation and coalescence of little holes, with the displaced material uniformly distributed between the holes, without visible rims. Our initial time $t = 0$ might correspond to the end of this preliminary process.

Equation 3 applies outside the dewetted region ($R_d(t) \leq r < \infty$). At the edge of the rim ($r = R_d(t)$), the rim height, $h_m(t)$, can be determined by taking into account capillary forces. The applied force on the rim, pushing the film away the dry area, must be balanced by the internal radial stress: $|S| = |\sigma_{rr}|h_m(t)$. Assuming the lateral extension of the film to be large enough, the film thickness must reach h_i far from the dry region: $\lim_{r \rightarrow \infty} h(r, t) = h_i$ ($\forall t$). The complete resolution of our set of equations 3-5-7 can be achieved using a method of characteristics [15]. Thereafter, all thicknesses will be made dimensionless by normalizing with a characteristic length $h^* \equiv |S|/\sigma_0$ (for Reiter's experimental conditions, we estimate h^* to be of the order of 500 Å).

Note first that for a purely viscous liquid ($\Phi(\dot{\gamma}\tau) = \dot{\gamma}\tau$),

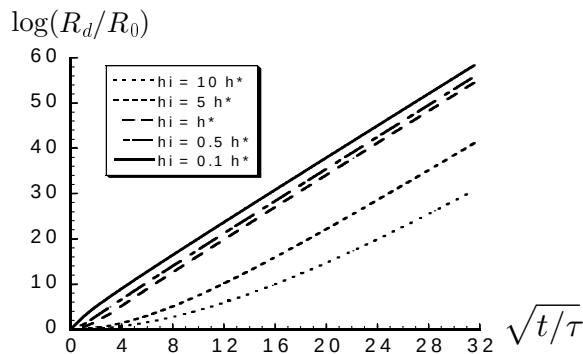


FIG. 4: Logarithmic plot of the dry zone radius R_d versus $\sqrt{t/\tau}$, for $h_i = 0.1, 0.5, 1, 5$ and $10 h^*$. Note the linear behaviour of $\log [R_d(t)/R_0]$ with $\sqrt{t/\tau}$ after a transient time.

our model leads to a constant and uniform thickness for the film, with an exponential growth of the dry radius:

$$R_d(t) = R_0 e^{\frac{|S|t}{\sigma_0 \tau h_i}} = R_0 e^{\frac{t}{\tau}} \quad (9)$$

This is in complete agreement with the experimental results of Debrégeas *et al.* for the dewetting of suspended polymer films [9] and supported films [21].

If we take into account the shear-thinning behavior of the polymer film ($\sigma^m(\dot{\gamma}) = \sigma_0 \ln(1 + \dot{\gamma}\tau)$) the dewetting front is quite different. An example of profile obtained for $h_i = 0.1h^*$ is shown in Fig.2. This profile is characterized by a highly asymmetric shape for the rim. There is a striking similarity between such a profile and those observed by Reiter for ultra-thin films [12]. On fig.3 we present the time evolution of this profile (for t ranging from $t = 0$ to $t = 5.10^{-2}\tau$, with a time step of $10^{-2}\tau$). The velocity field $v(r, t)$ is found to be almost proportional to $1/r$ at any time for thick profiles ($h_i \gg h^*$), similar to the long range radial plug flow observed by Debrégeas *et al.* [9]. We now focus on two natural parameters characterizing the film profile: the dry radius $R_d(t)$ and rim height $h_m(t)$.

In order to discuss the time dependence of the rim height, we need to compare h_i with the characteristic thickness h^* (in Fig. 5 we present our results for different initial thicknesses). For very thin profiles ($h_i \ll h^*$), the increase of rim height is initially very fast, whereas for thicker films ($h_i \gg h^*$), $h_m(t)$ is nearly constant during a long period of time, before growing faster. For the sake of conciseness, we will mainly focus on the case of thick films, for which simple scaling laws can be analytically obtained. As shown in Fig.5, for $h_i = 100h^*$ two different time regimes can be distinguished: at the beginning of hole formation, h_m is nearly constant and equals its initial value h_i . We have checked numerically (cf. Fig.5 b) that the anticipated analytical behaviour

$$h_m(t) \underset{t \gg t_0}{\sim} \frac{h^*}{2} \sqrt{t/\tau} \quad (10)$$

is obeyed after a crossover time $t_0 \approx \tau \left(\frac{h_i}{h^*}\right)^2$

In Fig.4, we present the time evolution of R_d for different initial thicknesses h_i . It is physically understandable that R_d , at a given time t , is larger for thinner films : for a given applied force $|S|$ per unit length, the thicker the film, the more the material to be displaced and the lower the dewetting velocity. Fig.4 shows that the following anticipated analytical behaviour is obeyed for $t \gg t_0$:

$$R_d(t) \underset{t \gg t_0}{\sim} R_\infty e^{4\sqrt{t/\tau}} \quad (11)$$

Note that the coefficient R_∞ strongly depends on h_i . During the early stage ($t \ll t_0$), the strain rates at the rim are constant and small, as a consequence of the constant large thickness. In this case, the rheological law of the film is viscous-type and the dry radius increases exponentially, as for the case previously discussed (see Eq.9). The range of thicknesses experimentally studied by Debrégeas *et al.* (5 to 250 μm) covers the domain $h_i \gg h^*$. As the corresponding crossover time is very large ($t_0 \gg \tau$), these experiments only covered mainly the first regime $t \ll t_0$ (this criterion $h_i \gg h^*$ is in fact a basic hypothesis of their “soft balloon” model [22]). The crossover to the $\exp(\sqrt{t})$ regime is a consequence of the non-linearity of rheological law 2.

The case $h_i \ll h^*$ will not be fully discussed here (cf. [15]). Briefly, we can note on Fig.5 that a sharp rim grows very quickly (with an initial speed $\dot{h}_m \approx h_i \exp(h^*/2h_i)$) at short times. In this regime, $h_m(t)$ is well described by the integral equation:

$$\int_{\frac{h^*}{2h_m(t)}}^{\frac{h^*}{2h_i}} \frac{e^{-x}}{x} dx \underset{t \ll \tau}{\approx} \frac{t}{\tau} \quad (12)$$

Later on, h_m and R_d reach the same laws of growth as in the case of thick films (Eqs.10 and 11).

In conclusion, our model accounts well for the exponential growth and the absence of rim characteristics of the dewetting regime observed by Debrégeas *et al.* for viscous polymer films. Taking into account the shear-thinning behaviour of the polymers near T_g enables us to see the modifications induced by this particular rheology on the film morphology [23]. It appears from our results that the early stages of dewetting for a shear-thinning polymer film are mainly determined by the ratio of its initial thickness h_i to a characteristic scale h^* (related to the driving force of the process, S , and the rheological response of the material, characterized by σ_0). In all cases, after a transient time depending on h_i , the rim height grows proportionally to $\sqrt{t/\tau}$ while the dry radius expands like $\exp(4\sqrt{t/\tau})$. The film profile exhibits a sharp, asymmetric rim similar to the one observed by Reiter in his latest experiments with ultrathin PS films. Work is now in progress to incorporate in our model the Laplace pressure (see [18]) which might lead to oscillatory dewetting fronts [11, 13], and to evaluate the possible effects

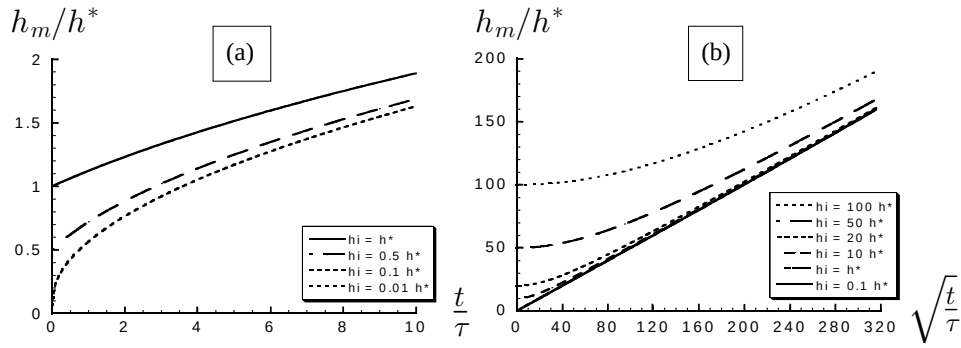


FIG. 5: Time evolution of the rim height h_m : **(a)** Plot of h_m versus t/τ , for $h_i = 0.01, 0.1, 0.5$ and $1 h^*$. Note that the curves corresponding to $h_i = 0.1$ and $0.01 h^*$ cannot be distinguished within the graph scale. **(b)** Plot versus $\sqrt{t/\tau}$ to show the linear behaviour of h_m with $\sqrt{t/\tau}$ after the transient time t_0 . For a thick film ($h_i \gg h^*$), two regimes can be distinguished. For $t < t_0 \sim \tau(h_i/h^*)^2$, h_m is constant and $R_d(t)$ increases exponentially with time. For $t > t_0$, h_m grows linearly with $\sqrt{t/\tau}$ and $R_d(t)$ expands like $\exp \sqrt{t/\tau}$.

of chain entanglements. In the future, we aim to study the dewetting of thin polymer films *below* T_g , where the existence of a yield stress in the rheological response of

the material may lead to new dewetting morphologies.

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